

Jitter operations (179.9.4.7) at TP1a (33dB) Version 1.4

Presented to IEEE P802.3dj Task Force 09/16/2024

Associated comments: 175,176, 178, 179

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Based on draft release of IEEE P802.3dj™/D1.0/1.1/1.1 Comments

Abstract: Performing 802.3dj clause 179.9.4.7 jitter operations have advanced with new measurement capabilities. This contribution summarizes jitter operations near 33dB through a conformant MTF and High Host loss serial configuration.

Supporters/Collaborators (Version 1.4)

Mike Dudek

Useful References:

IEEE 05/24 Contribution: https://www.ieee802.org/3/dj/public/24_05/calvin_3dj_01b_2405.pdf

IEEE 07/15 Contribution: https://www.ieee802.org/3/dj/public/24_07/calvin_3dj_01b_2407.pdf

IEEE 07/15 Contribution: https://www.ieee802.org/3/dj/public/24_07/calvin_3dj_02a_2407.pdf

RAN: https://www.ieee802.org/3/dj/public/24_07/ran_3dj_01b_2407.pdf

Diminico: https://www.ieee802.org/3/dj/public/23_11/diminico_3dj_01_2311.pdf

Instrumentation used in this contribution

M8042A/M8050A PG

- 5 Tap Tx de-emphasis (-.004, .013, -.056,.843, -.082, -.002, 0)
- 1000mV Tx differential amplitude

M8067A-005/003-Trace (1mm)

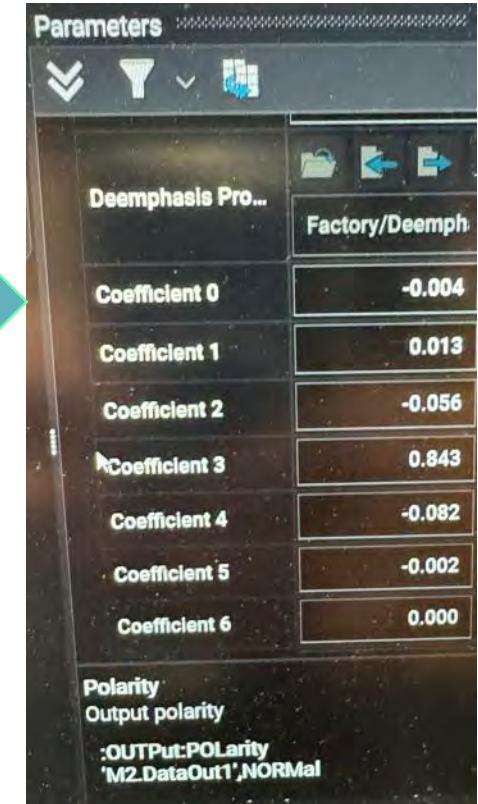
- 31.1dB @53.125GHz – (35mm + 185mm Traces)
- 2X pair of 1mm 8" phase matched cables (1.2dB each)
- Net TP1a test channel loss 33.5dB

UXR 1104B Real-Time scope

- DSP/SW Clock Recovery
- ~SIRC: 60GHz 4th order Bessel Thomson rolling off to -9dB @ 90GHz

N1000A+N1046A Sampling scope

- Prototype Clock Recovery
- SIRC: 60GHz 4th order Butterworth



Overview

May 2024 (P802.3dj D1.0) reviewed Jitter and VEC operations at TP2 (~27dB)

Instrument grade ISI structures.. SDD22 < -15dB

12Edge Jitter operations (instrument grade ISI structures.. SDD22 < -15dB)

- ✓ Physical CDR
- ✓ Oversampled/DSP CDR

VEC operations

- ✗ 1E-5 VEC
- ✓ 1E-3 VEC

July 2024 (P802.3dj D1.1) we repeated the above operations at TP1a (~33dB)

Instrument grade ISI structures.. SDD22 < -15dB

12Edge Jitter operations (instrument grade ISI structures.. SDD22 < -15dB)

- ✓ Physical CDR
- ✓ Oversampled/DSP CDR

VEC operations, not so successful (~12dB).

- ✗ 1E-5 VEC
- ✗ 1E-3 VEC
- ✓ 1E-2VEC

September 2024 (Objectives) << This presentation

Examine Jitter operations with a MTF in the higher TP1a loss profile

Discuss Return Loss implications and degrees of Jitter decomposition failure

IEEE 802.3dj D1.1 TP0d->TP1a loss

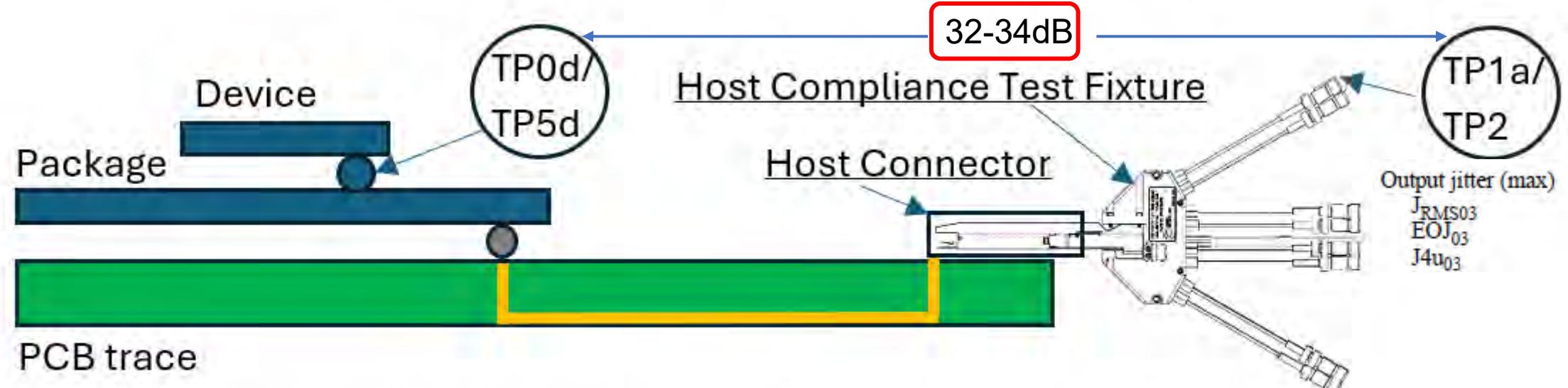


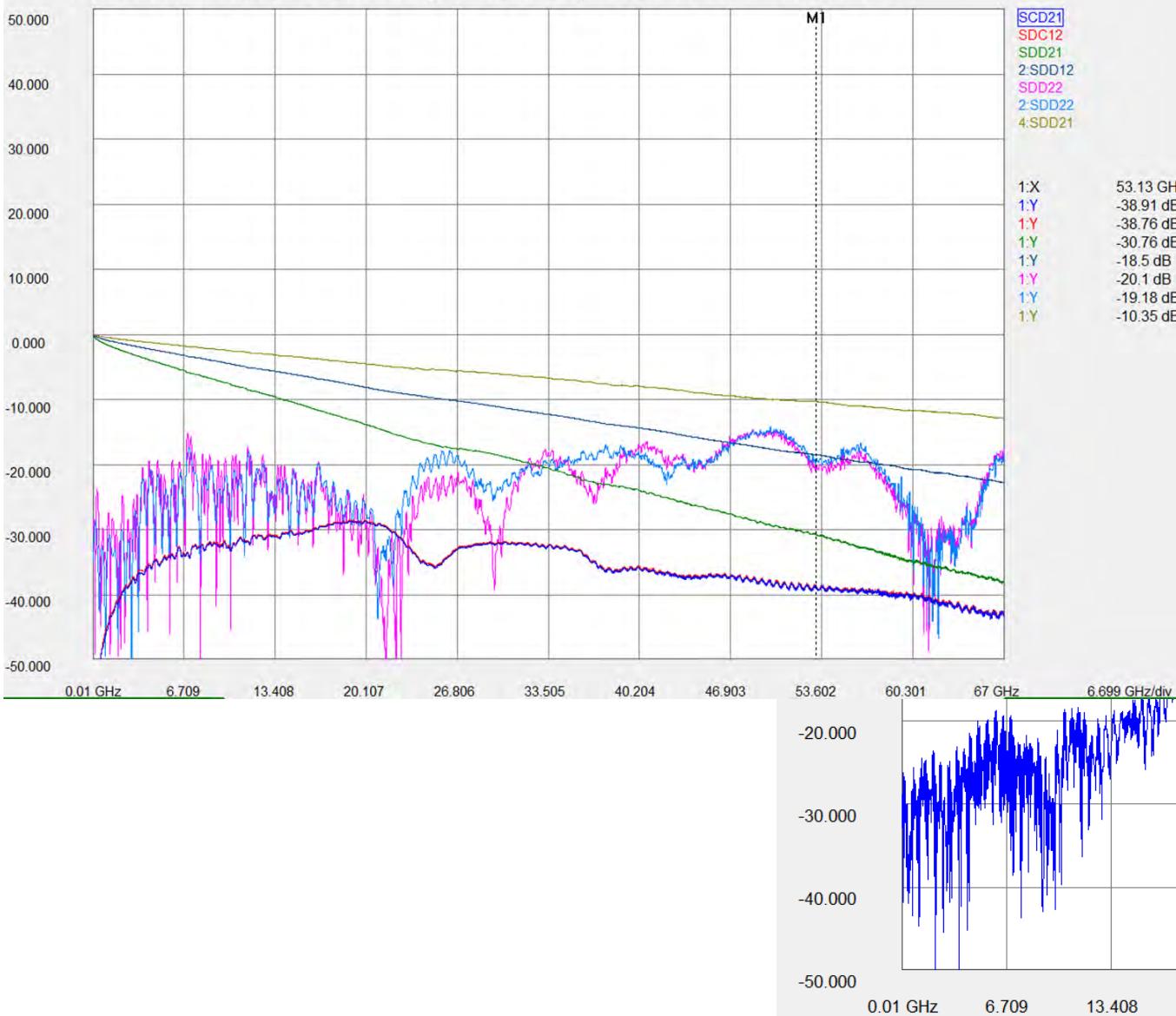
Figure 1: Typical 802.3dj host test point model

https://www.ieee802.org/3/dj/public/23_11/lusted_3dj_04_2311.pdf pg 5 (32dB)

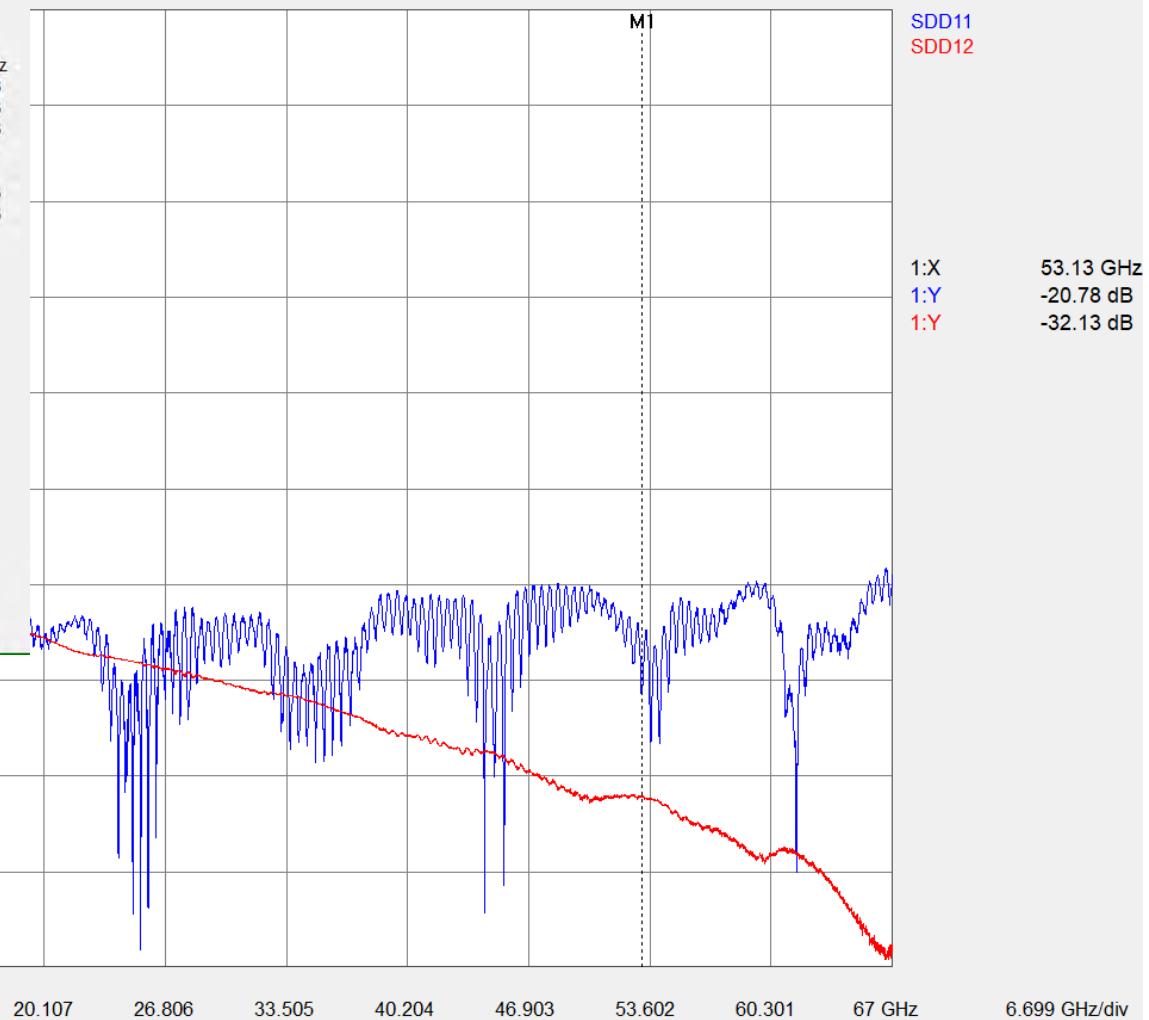
https://www.ieee802.org/3/dj/public/24_07/ran_3dj_01b_2407.pdf pg 10 (34dB)

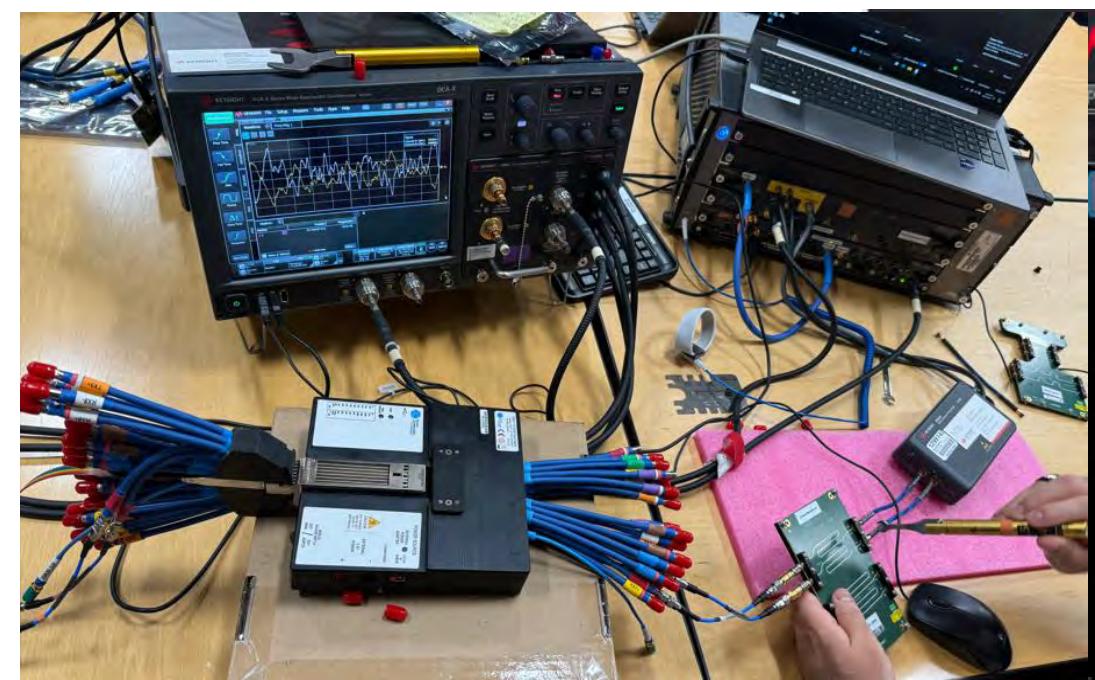
Laboratory grade ISI structures compared to MTF based structure

M8067A-005 Trace 1, Trace 2, Trace 2 + Trace 1



SDD11

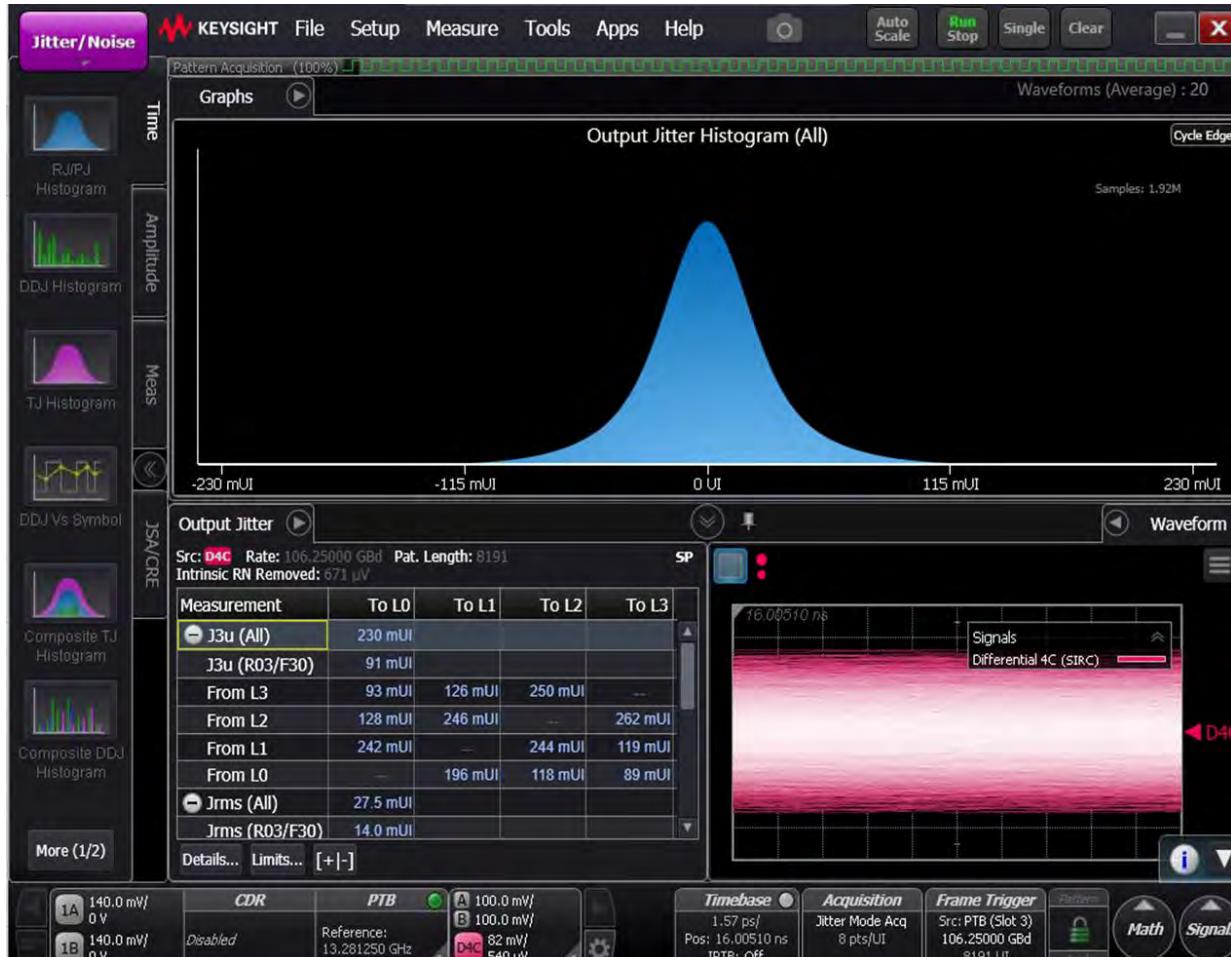




P8023dj: D3: V1.4 Jitter operations (179.9.4.7) at TP1a (33dB) 2024

ET Jitter (4BT-60GHz , Explicit Clock*, 33dB/MTF)

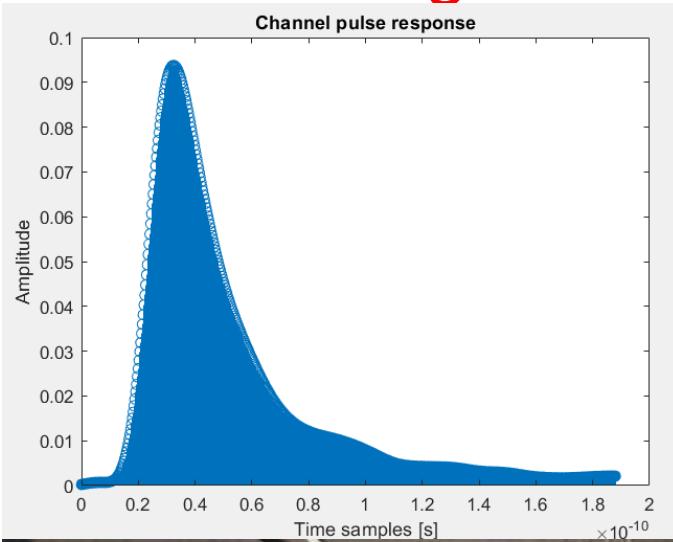
*Phase detection after 33dB is still under development.



Name	Source	To L0	Status	To L1	Status	To L2	Status	To L3	Status
J3u (All)	D4C	230 mUI	Correct	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)
J3u (R03/F D4C		91 mUI	Correct	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)
From L3	D4C	93 mUI	Correct	125 mUI	Correct	250 mUI	Correct	(n/a)	(n/a)
From L2	D4C	127 mUI	Correct	248 mUI	Correct	(n/a)	(n/a)	260 mUI	Correct
From L1	D4C	242 mUI	Correct	(n/a)	(n/a)	242 mUI	Correct	120 mUI	Correct
From L0	D4C	(n/a)	(n/a)	198 mUI	Correct	118 mUI	Correct	89 mUI	Correct
Jrms (All)	D4C	27.5 mUI	Correct	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)
Jrms (R03/ D4C		14.0 mUI	Correct	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)
From L3	D4C	14.3 mUI	Correct	19.0 mUI	Correct	37.5 mUI	Correct	(n/a)	(n/a)
From L2	D4C	19.8 mUI	Correct	37.0 mUI	Correct	(n/a)	(n/a)	39.0 mUI	Correct
From L1	D4C	36.5 mUI	Correct	(n/a)	(n/a)	37.0 mUI	Correct	18.2 mUI	Correct
From L0	D4C	(n/a)	(n/a)	30.5 mUI	Correct	18.2 mUI	Correct	13.7 mUI	Correct
EOJ (All)	D4C	17 mUI	Correct	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)
EOJ (R03/F D4C		7 mUI	Correct	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)	(n/a)
From L3	D4C	1 mUI	Correct	4 mUI	Correct	4 mUI	Correct	(n/a)	(n/a)
From L2	D4C	16 mUI	Correct	6 mUI	Correct	(n/a)	(n/a)	8 mUI	Correct
From L1	D4C	6 mUI	Correct	(n/a)	(n/a)	17 mUI	Correct	5 mUI	Correct
From L0	D4C	(n/a)	(n/a)	1 mUI	Correct	9 mUI	Correct	7 mUI	Correct

Precision 12Edge, TP1a Jitter decomposition is working well here.

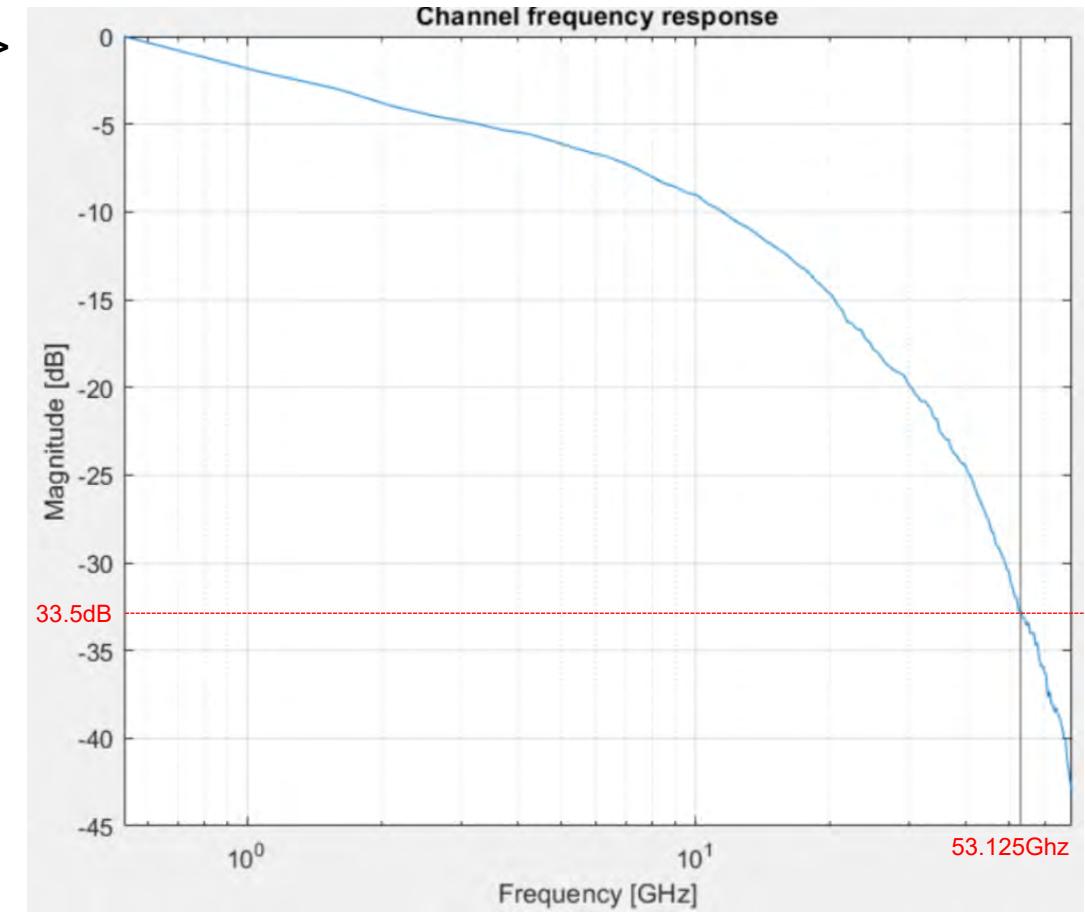
Channel configuration and Real-Time instrument used in this study:



Closest attainable physical proxies for (35mm + 185mm)
C2M/TP1a targeting (HL-HL) ~33dB

Reference : https://www.ieee802.org/3/dj/public/23_11/lusted_3dj_04_2311.pdf pg 5

PR ->SR ->IR->(FFT) =>



RT Jitter (4BT 60GHz BW , 1'st order PLL)



Instrument grade
SDD11 < -15dB
SDD21 33.5dB

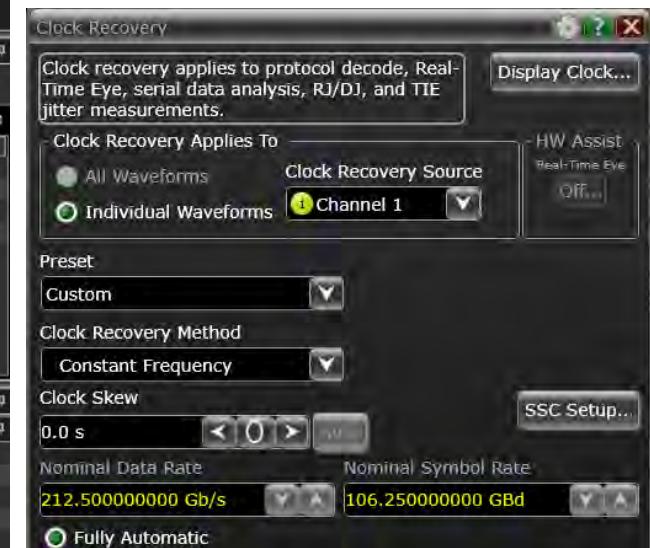


RT Jitter (4BT 60GHz BW , Constant Rate Clock)



Actual MTF + ISI (1mm)
SDD11 < -10dB
SDD21 33.5dB
Generator set to 1200mV

✗

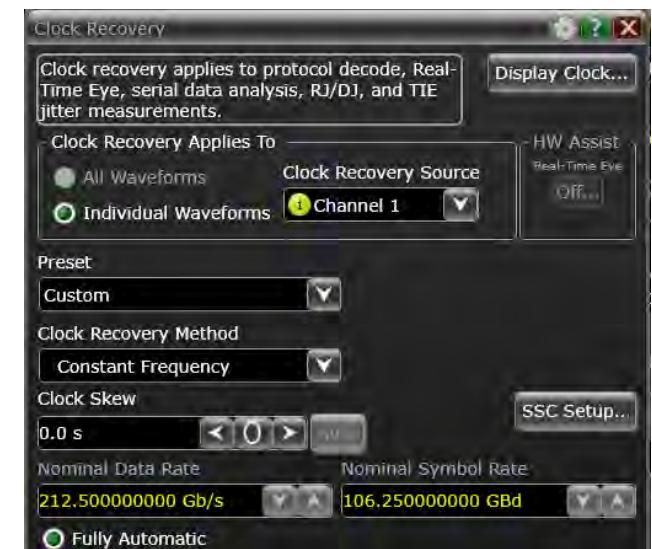


RT Jitter (4BT 60GHz BW , PLL)



Actual MTF + ISI (1mm)
SDD11 < -10dB
SDD21 33.5dB
Generator set to 1200mV

✗ ✗



Output jitter (max) analysis/ Possible ERL connection (

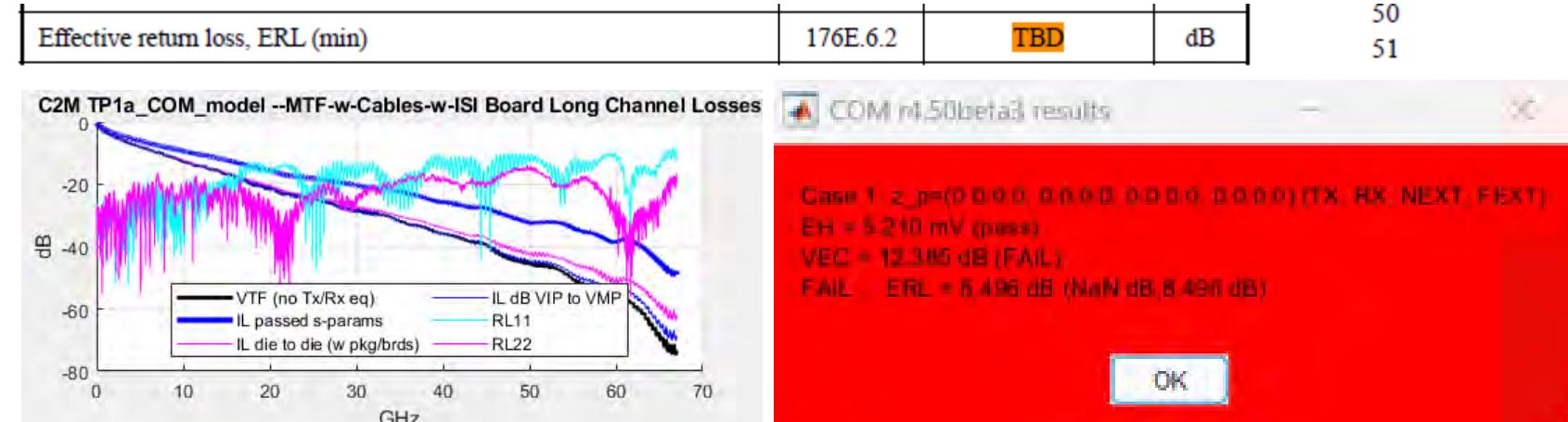
Tfx set to 0, Only applicable to C2M Nbx is the effect of the equalizer.

The OSFP MCB/HCB assembly has a SDD11 of nominally -10dB and an ERL of 8.49dB.

Is this low enough?
There is an existence proof of Jitter decomposition running well when it's < -16dB.

RT Instrument CDR's "should" and will eventually work under these conditions, but it's not ready today.

ET CDR is also work in progress



COM: New Entries

TDR_W_TXPKG	1	UI	ERL computed at TP1a
N_bx	0	UI	d1.0

Operational	
ERL Pass threshold	10
COM Pass threshold	3
DER_0	2.00E-05
T_r	0.00400
FORCE_TR	1
PMD_type	C2M

Summary

- The high-loss TP1a channel condition presents instrumentation with a few jitter decomposition challenges. While the final maximum ERL for a TP1a is still a TBD, the results suggest a sensitivity to this value being 8.49 (< 10dB). It's unclear where this problem clears, but it does not exist at 23dB
- With a 23dB ERL and a SDD11 of < -15dB 1'st order PLL operation and subsequent jitter decomposition work well (Page-10)

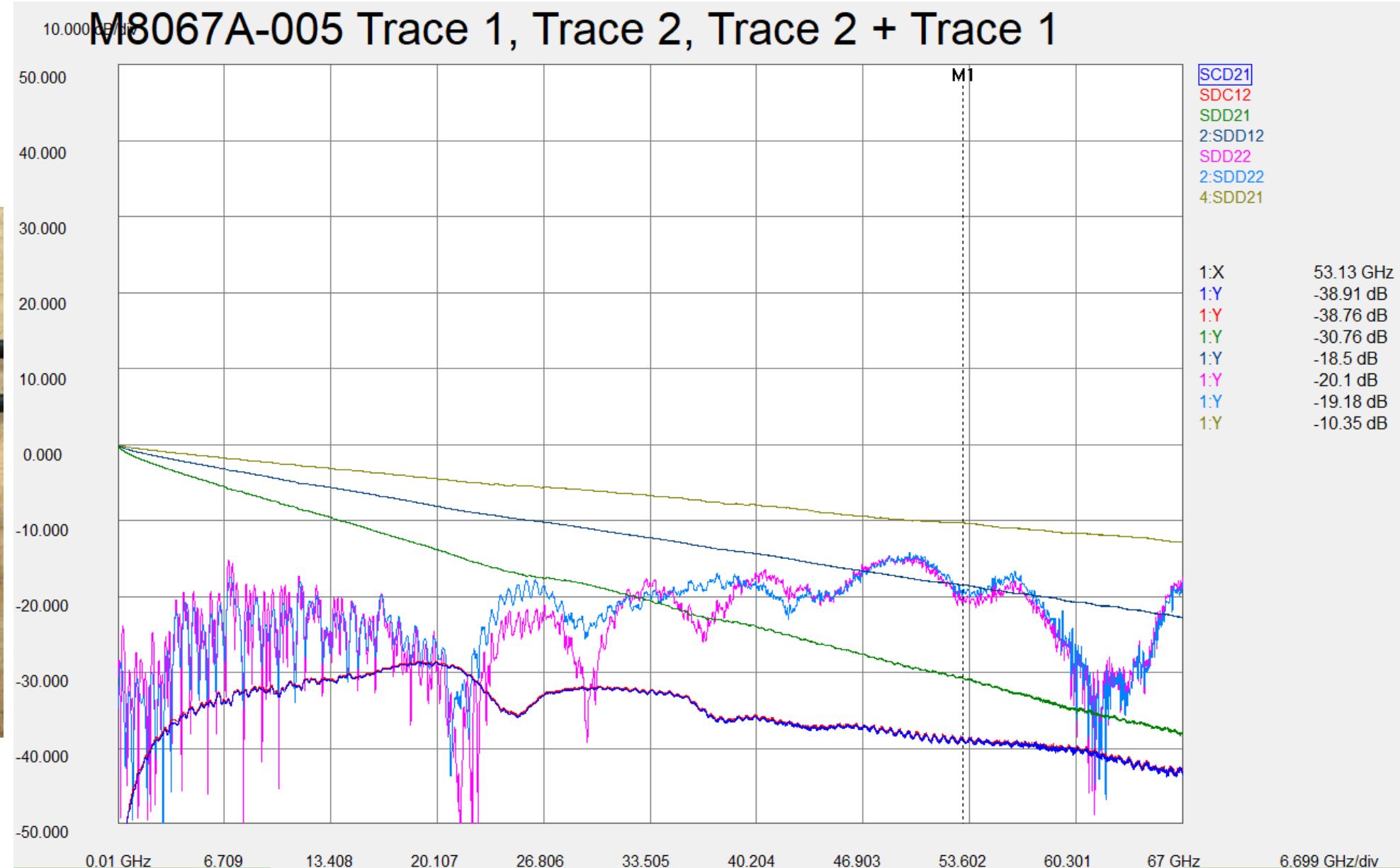
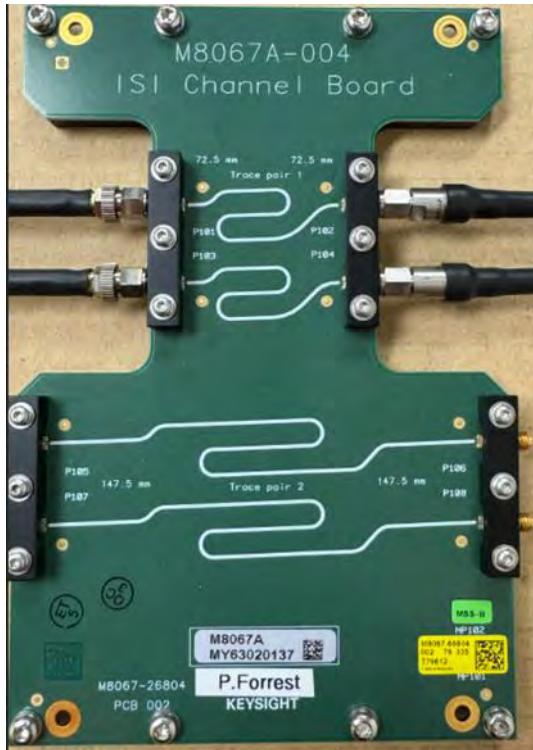
Ch 1-2 J3u Table (1266 Patterns)					Ch 1-2 J4u Table (1266 Patterns)					Ch 1-2 Jrms Table (1266 Patterns)					Ch 1-2 EOJ Table (1266 Patterns)				
Ref	To 10	To 11	To 12	To 13	Ref	To 10	To 11	To 12	To 13	Ref	To 10	To 11	To 12	To 13	Ref	To 10	To 11	To 12	To 13
A0	7.244372 mU				A0	7.386725 mU				A0	7.18.9013 mU				A0	6.79463 mU			
L3	/ 81.5677 mU	/ 173.983 mU	267.074 mU		L3	1.84.9584 mU	/ 129.426 mU	287.000 mU		L3	7.945985 mU	/ 12.8463 mU	31.3019 mU		L3	1.44443 mU	/ 82.541 mU	5.40748 mU	
L2	127.760 mU	/ 181.101 mU		331.644 mU	L2	142.201 mU	/ 181.672 mU		245.236 mU	L2	16.7120 mU	/ 29.3827 mU		76.3028 mU	L2	32.5772 mU	6.23461 mU		5.33742 mU
L1	196.060 mU		7.209.346 mU	7.104.455 mU	L1	214.039 mU		7.222.544 mU	7.311.176 mU	L1	35.2649 mU		7.2.0357 mU	7.11.0157 mU	L1	1.44443 mU	2.02236 mU	2.30177 mU	
L0		281.664 mU	142.027 mU	7.80.340 mU	L0		284.419 mU	158.771 mU	7.83.4804 mU	L0		32.4161 mU	18.2551 mU	7.8.3931 mU	L0		4.08015 mU	3.25772 mU	6.23463 mU

An analysis and planned improvements to the PLL/CDR system are underway, as this 5dB difference SDD11 should not trigger a jitter decomposition failure. The fact that changing from a 1'st order PLL to a constant-rate recovery method indicates the failure is not in the jitter, rather it's the PLL system.

Thank you

Backup

- M8067A-005 ISI trace Performance



Backup “Support of 178.9.2 Transmitter characteristics”

Draft Amendment to IEEE Std 802.3-2022

IEEE P802.3dj 200 Gb/s, 400 Gb/s, 800 Gb/s, and 1.6 Tb/s Ethernet Task Force

IEEE Draft P802.3dj/D1.1

11 July 2024

Unless otherwise specified, transmitter signal measurements are made for each lane separately using a fourth-order Bessel-Thomson low-pass response with a 3 dB bandwidth of 60 GHz, with AC-coupled connection from TP0v to the test equipment.

- Tx: 300 mV SE amplitude. 106.25GHz clock recovery. PRBS13Q (IEEE/PRBS13Q_Lane0_bit). 4PAM Gray coded. No de-emphasis. No impairments.
- Channel: 35 mm ISI board (approx.. 6.5 dB channel loss at 53 GHz counting cables).
- Real-Time instrumentation test case.

Test case	VEC [dB]	J3u all [mUI]	Jrms all [mUI]
No BW limit (113 GHz brick)	7.79	153	18.3
70 GHz brick	6.94	160.6	17.4
60 GHz Butter. 75 GHz brick	6.06	137.8	15.4
60 GHz Bessel. 90 GHz brick	5.67	125.2	15.2

27dB



27dB Jitter detail

Ch 1 J4u Table (211 Patterns)				
From	To L0	To L1	To L2	To L3
All	97.3328 mUI			
L3	92.1533 mUI	172.216 mUI	332.564 mUI	
L2	127.237 mUI	321.454 mUI	332.555 mUI	
L1	302.398 mUI	274.261 mUI	156.882 mUI	
L0	184.394 mUI	152.146 mUI	102.191 mUI	

Ch 1 JRMS Table (211 Patterns)				
From	To L0	To L1	To L2	To L3
All	14.3023 mUI			
L3	13.6770 mUI	21.3265 mUI	43.6720 mUI	
L2	19.9056 mUI	41.1484 mUI	45.6129 mUI	
L1	44.4066 mUI	39.4035 mUI	20.4631 mUI	
L0	40.7605 mUI	23.7361 mUI	14.8996 mUI	

Ch 1 EOJ Table (211 Patterns)				
From	To L0	To L1	To L2	To L3
All	13.0678 mUI			
L3	792.762 μUI	3.14140 mUI	11.4783 mUI	
L2	6.53361 mUI	12.7884 mUI	6.08881 mUI	
L1	792.762 μUI	457.750 μUI	13.0678 mUI	
L0	3.89695 mUI	6.53361 mUI	12.7884 mUI	

A typical physical layer validation screen shot is presented in this screen shot illustrated above, as the Jitter decomposition traditionally emphasizes all 12 of the available PAM4 transitions. For P802.3dj the draft specifications emphasize a limited set of 0 to 3 and 3 to 0 transitions. In this example the $J4U_{03}$ reported value is 97mUI against a typical spec limit of nominally 135mUI. $JRMS_{03}$ is reporting 14.3mUI against a nominal limit of 23mUI and the EOJ_{03} value of 13mUI against a nominal limit of 25mUI.

COM 4.5b3 analysis of MTF + ISI = 33.5dB. ERL 8.496dB

Figure 301: 32.1dB IL Channel: Raw frequency-domain data

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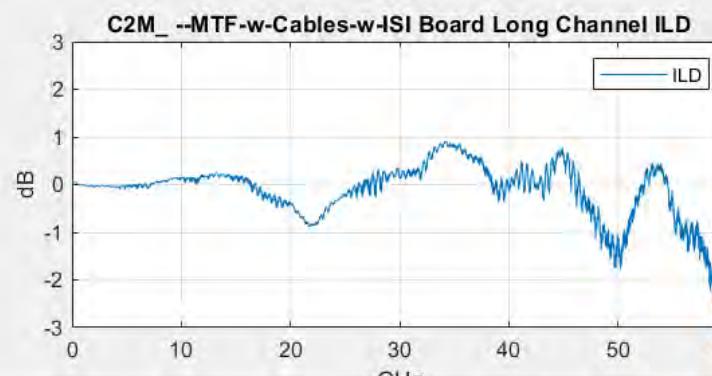
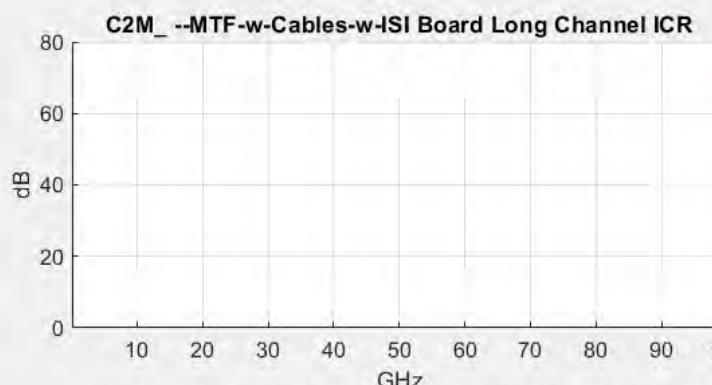
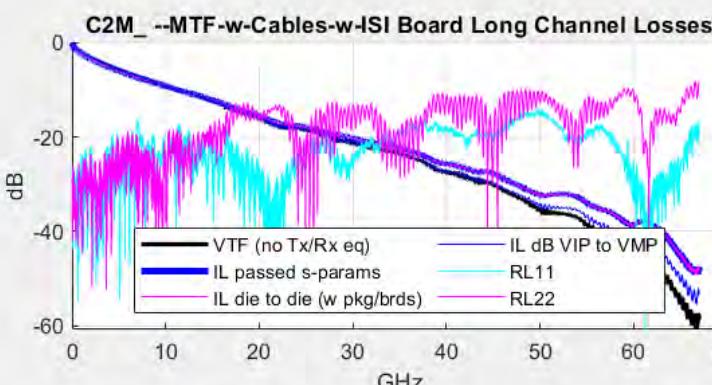
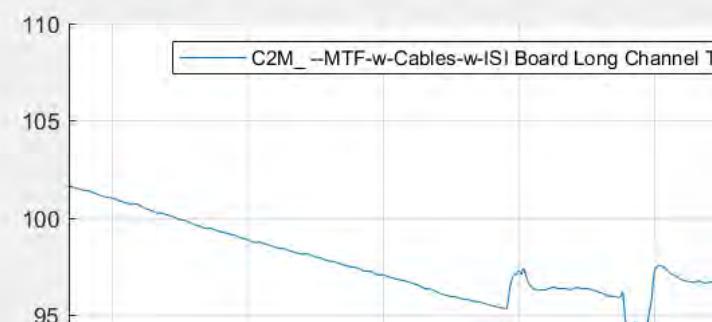


Figure 180

File Edit View Insert Tools Desktop Window Help



TDR TX PTDR TX TDR RX PTDR RX



COM r4.50beta3 results

Case 1: z_p=(0.0 0.0, 0.0 0.0, 0.0 0.0) (TX, RX, NEXT, FEXT)
EII = 5.210 mV (pass)
VEC = 12.385 dB (FAIL)
FAIL - ERL = 8.496 dB (NaN dB 8.496 dB)

OK

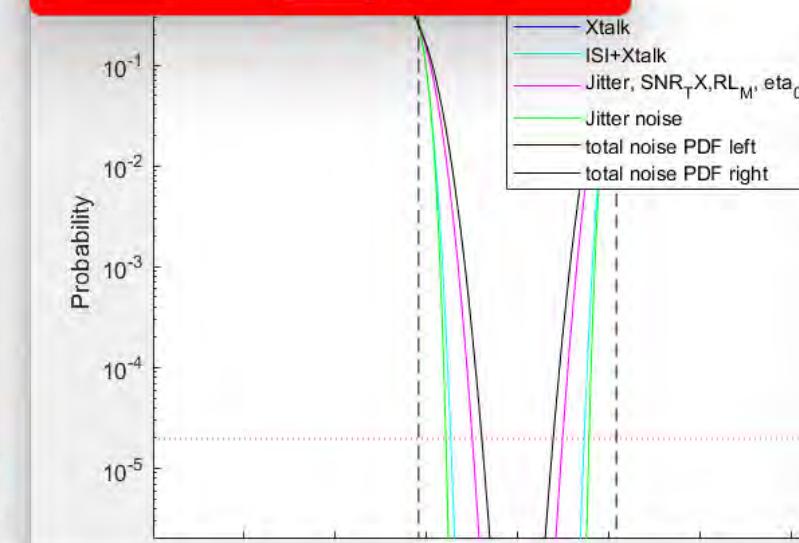
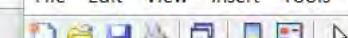
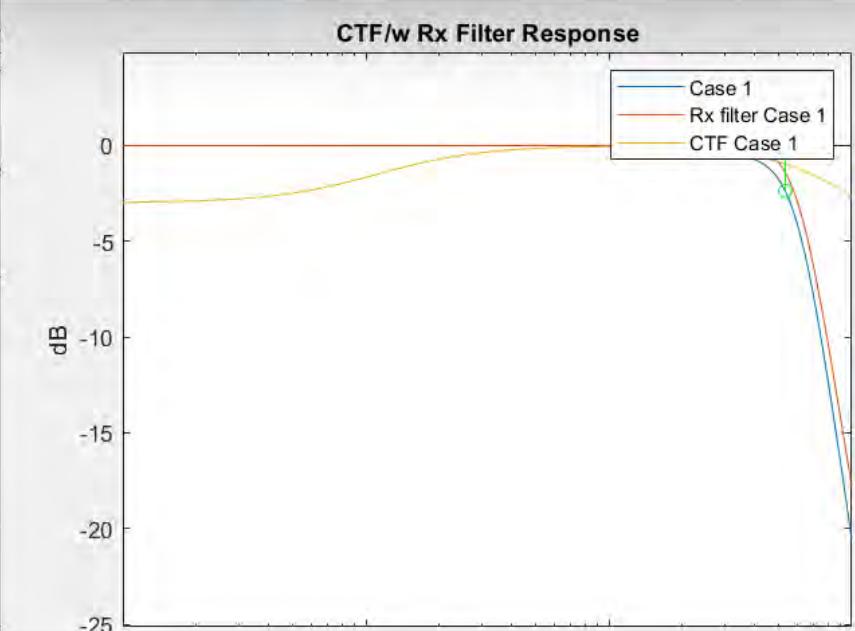
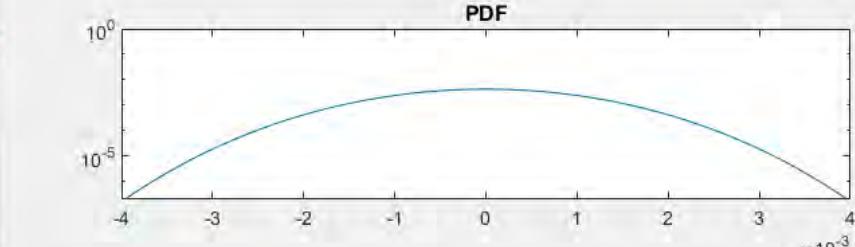
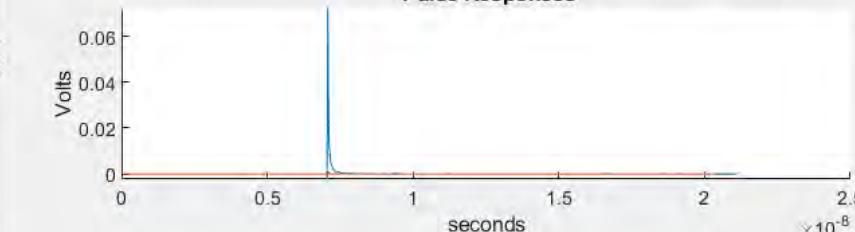


Figure 151: Case 1 PR & PDF - C2M_ --MTF-w-Cables-w-ISI Board Long...

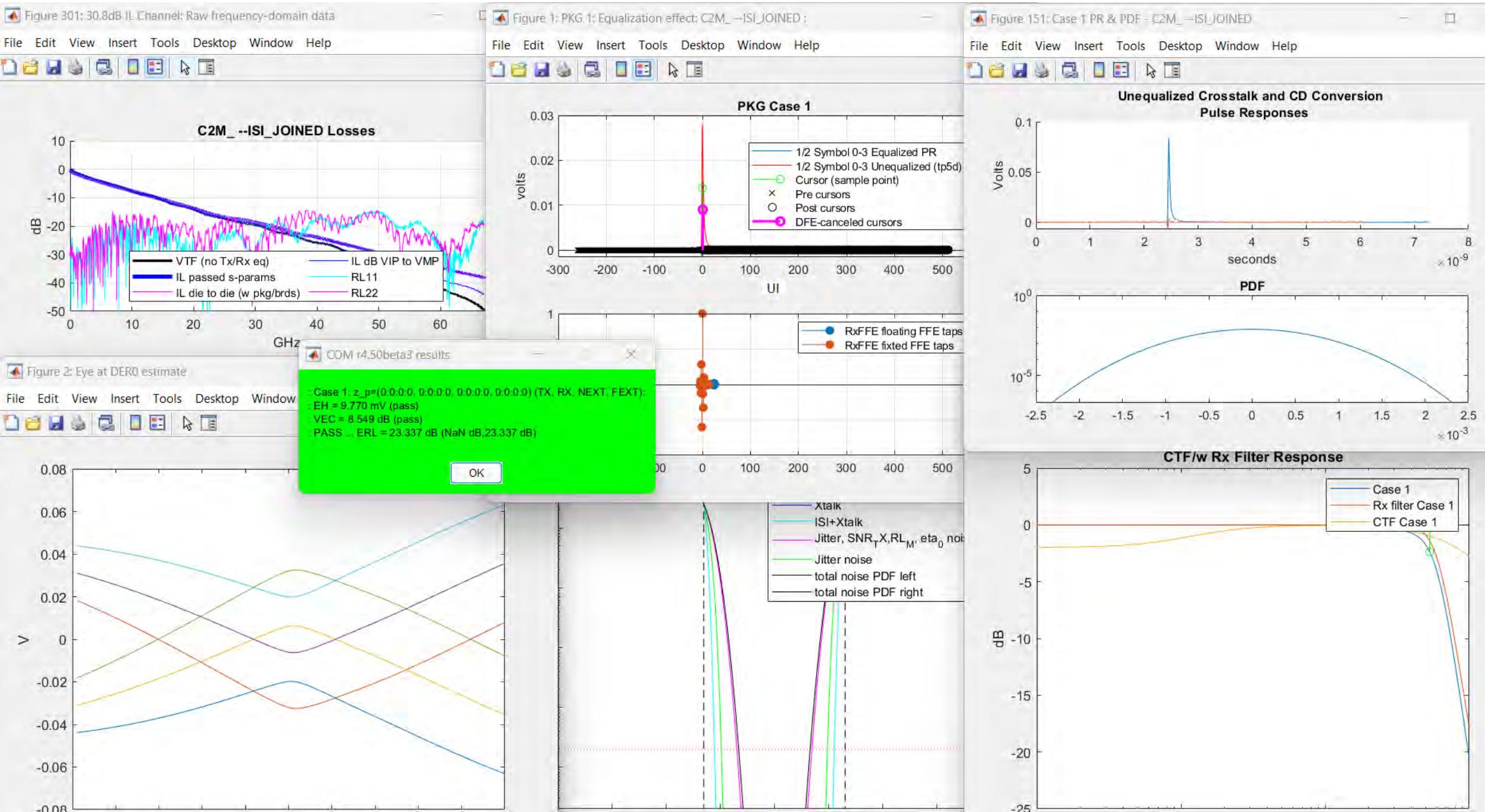
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Unequalized Crosstalk and CD Conversion Pulse Responses



COM 4.5b3 analysis of ISI + ISI = 33.5dB. ERL 23.337dB



C2M COM Spreadsheet (1/2)

A	B	C	D	E	F	G	H	I	J	K	L	M	N	O	P	Q			
Table 93A-1 parameters																			
Parameter	Setting	Units	Information	stds ref.	I/O control	stds ref.			Parameter	Setting	Units	Information	stds ref.	SAVE_CONFIG2MAT	0	Receiver testing			
f_b	106.25	GHz			DIAGNOSTICS	1	logical		package_t1_gamma0_a1_a2	5e-4 0.00065 0.0003			RX_CALIBRATION	0	logical				
f_min	0.05	GHz			DISPLAY_WINDOW	1	logical		package_t1_tau	0.006141	ns/mm		Sigma_BBN_step	5.00E-03	V				
Delta_f	0.01	GHz			CSV_REPORT	0	logical		package_z_c	92; 70; 70; 80; 80; 100	Ohm		ICN parameters						
C_d	[0.4e-4 0.9e-4 1.1e-4 0.4e-4 0.9e-4 1.1e-4]	nF	[TX RX]	d1.0	RESULT_DIR	.\results\C2M_{date}\			z_p(TX)	:11 11; 1111; 0.50	mm	[test cases to run]	f_v	0.278	Fb				
L_s	[0.13 0.15 0.14; 0.13 0.15 0.14]	nH	[TX RX]	d1.0	SAVE FIGURES	0	logical		z_p(NEXT)	:11 11; 1111; 0.50	mm	[test cases]	f_f	0.278	Fb				
C_b	[0.3e-4 0.3e-4]	nF	[TX RX]	d1.0	Port Order	[2 4 1 3]	input fi		z_p(FEXT)	:11 11; 1111; 0.50	mm	[test cases]	f_n	0.278	Fb				
R_0	50	Ohm	[TX RX]	d1.0 cmt 396	RUNTAG	C2M_			z_p(RX)	:11 11; 1111; 0.50	mm	[test cases]	f_2	60.000	GHz				
R_d	[46.25 46.25]	Ohm	[TX RX]		COM_CONTRIBUTION	0	logical		C_p	[0.4e-4 0.4e-4]	nF	[test cases]	A_ft	0.450	V				
PKG_NAME	CLASSB	TST_EQUIP	PKG_Module_TST_EQUIP	TX RX	module is really TBD		TDR and ERL options		Operational				A_nt	0.450	V				
A_V	0.413	V					TDR	1	logical	ERL Pass threshold	10	dB							
A_fe	0.413	V					ERL	1	logical	COM Pass threshold	3	dB	d1.0 cmt 250	Parameter	Setting				
A_ne	0.45	V					ERL_ONLY	0	logical	DER_0	2.00E-05		board_t1_gamma0_a1_a2	7.277845e-04 4.7955e-03	1.0 db/in @ 53.125G				
z_p select	[1]						TR_TDR	0.005	ns	d1.0 cmt 48	T_r	0.00400	ns	d1.0 176E.4.2	board_t1_tau	5.730E-03	ns/mm		
L	4						N	1600	UI	FORCE_TR	1	logical		required for backward compatibility	board_Z_c	100	Ohm		
M	32						TDR_Butterworth	1		PMD_type	C2M		d1.0 176E.4.2		z_bp(TX)	32	mm		
	filter and Eq						beta_x	0		samples_for_C2M	100				z_bp(NEXT)	32	mm		
f_r	0.565	*fb		d1.0 cmt 60 (60 GHz)			rho_x	0.618		T_O	50				z_bp(FEXT)	32	mm		
c[0]	0.54		min	d1.0 cmt 37			TDR_W_TXPKG	1	UI	ERL computed at TP1a	Ew	1			z_bp(RX)	32	mm		
c[-1]	0	0.34:0.02: [min:step:max]		d1.0 cmt 37			N_bx	0	UI	MLSE	0	logical			C_0	[0.02e-4]	nF		
c[-2]	0	0.02:0.14: [min:step:max]		d1.0 cmt 37			fixture_delay_time	[0.17e-9]	5	ts_anchor	1				C_1	[0.02e-4]	nF		
c[-3]	0	0	[min:step:max]				Tukey_Window	1		sample_adjustment	[-12 12]				Include PCB	0	logical		
c[-4]	0	0	[min:step:max]				Noise_jitter			Local Search	0				Selections (rectangle, gaussian, dual_rayleigh, triangle)				
c[-1]	0	-0.2:0.02: [-0.2:0.02: [min:step:max]]		d1.0 cmt 37	Host chip to Module (AUI)		sigma_RJ	0.01	UI	d1.0 cmt 271	Filter: Rx FFE				Histogram_Window_Weight	gaussian	selection		
N_b	1		UI	d1.0			A_DD	0.02	UI	d1.0 cmt 271	ffe_pre_tap_len	5	UI	d1.0 cmt 72	Or	32	UI		
b_max(1)	0.85		As/dffe1	d1.0 cmt 279			eta_0	1.00E-08	V/A2/GHz	d1.0 cmt 269 straw poll	ffe_post_tap_len	14	UI	d1.0 cmt 72					
b_max(2,N_b)	0		As/dffe2_N_b				SNR_TX	33	dB	d1.0 cmt 45	ffe_pre_tap1_max	0.7	interpreted as +/-	d1.0 cmt 279					
b_min(2,N_b)	-0.15		UJ	NA if Nb=1			R_LM	0.95		d1.0 cmt 273	ffe_post_tap1_max	0.7	interpreted as +/-	d1.0 cmt 279					
g_DC	0		dB	[-20:1:0]			d1.0			ffe_tapn_max	0.7	interpreted as +/-	d1.0 cmt 279						
f_z	42.50	GHz		d1.0						FFE_OPT_METHOD	MMSE				FV-LMS or MMSE				
f_p1	42.50	GHz		d1.0						num_ui_RXFF_noise	1024								
f_p2	106.25	GHz		d1.0						Floating Tap Control									
g_DC_HP	[-6:1:0]		[min:step:max]	d1.0						N_bg	2	0 12 or 3 groups	d1.0 cmt 72						
f_HP_PZ	1.328125	GHz		d1.0						N_bf	4	taps per group	d1.0 cmt 72						
Butterworth	1	logical	include in fr							N_f	50	UI span for floating taps	d1.0 cmt 72						
										bmaxg	0.2	max DFE value for floating taps							
										B_float_RS5_MAX	1	rss tail tap limit							
										N_tail_start	15	(UI) start of tail taps limit	d1.0 cmt 72						

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41	.START	PKG_LowR_CLASSA	[2.44 5.7] db	
42	Table 93A-3 parameters			
43	Parameter	Setting	Units	Information
44	package_tl_gamma0_a1_a2	[0.0005 0.00089 0.0002]		d1.0
45	package_tl_tau	0.006141	ns/mm	d1.0
46	package_Z_c	[87.5 87.5; 95 95; 100 100; 100 100]	Ohm	d1.0
47	R_d	[46.25 46.25]	Ohm [TX RX]	d1.0 cmt 396
48	z_p(TX)	[12 33 33 33; 181 181 18; 0000 ; 0000]	mm [test cases]	d1.0
49	z_p(NEXT)	[12 33 33 33; 181 181 18; 0000 ; 0000]	mm [test cases]	d1.0
50	z_p(FEXT)	[12 33 33 33; 181 181 18; 0000 ; 0000]	mm [test cases]	d1.0
51	z_p(RX)	[12 33 33 33; 181 181 18; 0000 ; 0000]	mm [test cases]	d1.0
52	C_p	[0.4e-4 0.4e-4]	nF [TX RX]	d1.0
53	A_v	0.413	V Vf=0.400	d1.0 cmt 434
54	A_fe	0.413	V Vf=0.399	d1.0 cmt 434
55	A_ne	0.45	V Vf=0.400	d1.0 cmt 434
56	.END			
57	.START	PKG_HIR_CLASSB	[2.8 5.6 6.7 9.4] db	
58	Table 93A-3 parameters			
59	Parameter	Setting	Units	Information
60	package_tl_gamma0_a1_a2	[0.0005 0.00065 0.000293]		d1.0
61	package_tl_tau	0.006141	ns/mm	d1.0
62	package_Z_c	[87.5 87.5; 95 95; 100 100; 78 78]	Ohm	d1.0
63	R_d	[46.25 46.25]	Ohm [TX RX]	d1.0 cmt 396
64	z_p(TX)	[8 24 30 45; 22 22; 13 13 13 13; 15 15 15 15]	mm [test cases]	d1.0
65	z_p(NEXT)	[8 24 29 44; 22 22; 13 13 13 13; 15 15 15 15]	mm [test cases]	d1.0
66	z_p(FEXT)	[8 24 30 45; 22 22; 13 13 13 13; 15 15 15 15]	mm [test cases]	d1.0
67	z_p(RX)	[8 24 29 44; 22 22; 13 13 13 13; 15 15 15 15]	mm [test cases]	d1.0
68	C_p	[0.4e-4 0.4e-4]	nF [TX RX]	d1.0
69	A_v	0.413	V Vf=0.400	d1.0 cmt 434
70	A_fe	0.413	V Vf=0.399	d1.0 cmt 434
71	A_ne	0.45	V Vf=0.400	d1.0 cmt 434
72	.END			
73	.START	PKG_HIR_CLASSB_TST_EQUIP	[2.8 5.6 6.7 9.4] db	
74	Table 93A-3 parameters			
75	Parameter	Setting	Units	Information
76	package_tl_gamma0_a1_a2	[0.0005 0.00065 0.000293]		d1.0
77	package_tl_tau	0.006141	ns/mm	d1.0
78	package_Z_c	[87.5 87.5; 95 95; 100 100; 78 78]	Ohm	d1.0
79	R_d	[46.25 46.25]	Ohm [TX RX]	d1.0 cmt 396
80	z_p(TX)	[0 000 0 000; 0 000 ; 0 000]	mm [test cases]	d1.0
81	z_p(NEXT)	[0 000 0 000; 0 000 ; 0 000]	mm [test cases]	d1.0
82	z_p(FEXT)	[0 000 0 000; 0 000 ; 0 000]	mm [test cases]	d1.0
83	z_p(RX)	[0 000 0 000; 0 000 ; 0 000]	mm [test cases]	d1.0
84	C_p	[00]	nF [TX RX]	d1.0
85	A_v	0.413	V Vf=0.400	d1.0 cmt 434
86	A_fe	0.413	V Vf=0.399	d1.0 cmt 434
87	A_ne	0.45	V Vf=0.400	d1.0 cmt 434
88	.END			

91	.START	PKG_Module_TST_EQUIP		
92	Table 93A-3 parameters			
93	Parameter	Setting	Units	Information
94	package_tl_gamma0_a1_a2	[0.0005 0.00069 0.0002]		
95	package_tl_tau	0.006141	ns/mm	
96	package_Z_c	[87.5 87.5; 95 95; 100 100; 100 100]	Ohm	
97	C_b	[0.3e-4 0.5e-4]	nF [TX RX]	
98	R_d	[50 50]	Ohm [TX RX]	
99	z_p(TX)	[0 000 ; 0 000 ; 0 000]	mm [test cases]	
100	z_p(NEXT)	[0 000 ; 0 000 ; 0 000]	mm [test cases]	
101	z_p(FEXT)	[0 000 ; 0 000 ; 0 000]	mm [test cases]	
102	z_p(RX)	[0 000 ; 0 000 ; 0 000]	mm [test cases]	
103	C_p	[00]	nF [TX RX]	
104	A_v	0.413	V Vf=0.400	
105	A_fe	0.413	V Vf=0.399	
106	A_ne	0.45	V Vf=0.400	
107	.END			
108	.START	PKG_Module		
109	Table 93A-3 parameters			
110	Parameter	Setting	Units	Information
111	package_tl_gamma0_a1_a2	[0.0005 0.00089 0.0002]		
112	package_tl_tau	0.006141	ns/mm	
113	package_Z_c	[87.5 87.5; 95 95; 100 100; 100 100]	Ohm	
114	R_d	[50 50]	Ohm [TX RX]	
115	z_p(TX)	[8 8 8 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
116	z_p(NEXT)	[8 8 8 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
117	z_p(FEXT)	[8 8 8 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
118	z_p(RX)	[8 8 8 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
119	C_p	[0.4e-4 0.4e-4]	nF [TX RX]	
120	A_v	[0.4057 0.4057 0.4057 0.4057]	V Vf=0.400	
121	A_fe	[0.4057 0.4057 0.4057 0.4057]	V Vf=0.399	
122	A_ne	[0.600 0.600 0.600 0.600]	V Vf=0.400	
123	.END			
124	.START	PKG_Null		
125	Table 93A-3 parameters			
126	Parameter	Setting	Units	Information
127	package_tl_gamma0_a1_a2	[5e-4 0.001 0.03]		
128	package_tl_tau	0.006141	ns/mm	
129	package_Z_c	[92 92 ; 70 70 ; 80 80 ; 100 100]	Ohm	
130	R_d	[50 50]	Ohm [TX RX]	
131	z_p(TX)	[0 000 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
132	z_p(NEXT)	[0 000 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
133	z_p(FEXT)	[0 000 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
134	z_p(RX)	[0 000 ; 0 000 ; 0 000 ; 0 000]	mm [test cases]	
135	C_p	[00]	nF [TX RX]	
136	A_v	0.5	V Vf=0.400	
137	A_fe	0.5	V Vf=0.400	
138	A_ne	0.61	V Vf=0.400	
139	.END			